

N-Channel Enhancement Mode Power MOSFET

Description

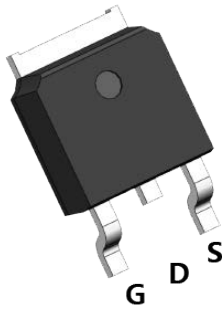
The HLDD2N60 uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.

Application

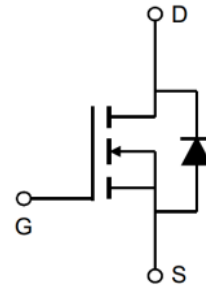
- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply

Features

- $V_{DS} = 600V, I_D = 2A$
- $R_{DS(ON)} : 5\Omega @ V_{GS} = 10V$
- Low gate charge.
- Green device available.
- Advanced high cell density trench technology for ultra $R_{DS(ON)}$.
- Excellent package for good heat dissipation.



Marking and pin assignment



N-Channel MOSFET

Absolute Maximum Ratings ($T_C = 25^\circ\text{C}$ unless otherwise noted)

| Parameter | Symbol | Limit | Unit |
|--|--------------------------|------------|--------------------|
| Drain-Source Voltage | V_{DS} | 600 | V |
| Gate-Source Voltage | V_{GS} | ± 30 | V |
| Drain Current-Continuous | I_D | 2 | A |
| Drain Current-Continuous ($T_C = 100^\circ\text{C}$) | $I_D(100^\circ\text{C})$ | 1.3 | A |
| Pulsed Drain Current | I_{DM} | 6 | A |
| Maximum Power Dissipation | P_D | 130 | W |
| Derating factor | | 0.43 | $W/^\circ\text{C}$ |
| Single pulse avalanche energy ^(Note 5) | E_{AS} | 120 | mJ |
| Operating Junction and Storage Temperature Range | T_J, T_{STG} | -55 To 175 | $^\circ\text{C}$ |

Thermal Characteristic

| | | | |
|--|-----------------|------|--------------------|
| Thermal Resistance, Junction-to-Case ^(Note 2) | $R_{\theta JC}$ | 0.43 | $^\circ\text{C/W}$ |
|--|-----------------|------|--------------------|

Package Marking and Ordering Information

| Part NO. | Marking | Package |
|----------|----------|---------|
| HLDD2N60 | HLDD2N60 | TO-252 |

Electrical Characteristics (T_C=25°C unless otherwise noted)

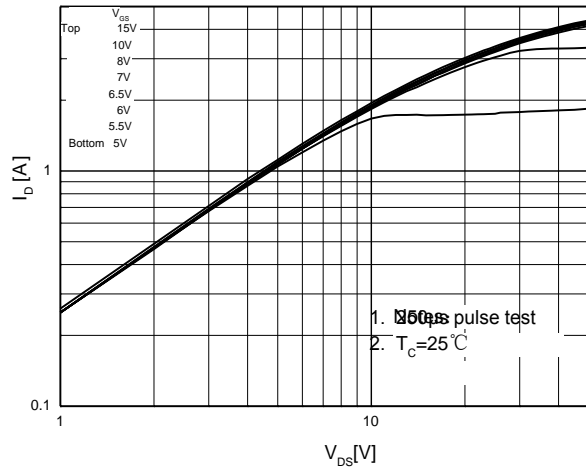
| Parameter | Symbol | Condition | Min | Typ | Max | Unit |
|---|---------------------|--|-----|------|------|------|
| Off Characteristics | | | | | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | V _{GS} =0V, I _D =250μA | 600 | - | - | V |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} =600V, V _{GS} =0V | - | - | 10 | μA |
| Gate-Body Leakage Current | I _{GSS} | V _{GS} =±30V, V _{DS} =0V | - | - | ±100 | nA |
| On Characteristics (Note 3) | | | | | | |
| Gate Threshold Voltage | V _{GS(th)} | V _{DS} =V _{GS} , I _D =250μA | 2 | - | 4 | V |
| Drain-Source On-State Resistance | R _{DS(ON)} | V _{GS} =10V, I _D =1A | - | 3.8 | 5 | Ω |
| | | V _{GS} =4.5V, I _D =0A | - | - | - | |
| Forward Transconductance | g _{FS} | V _{DS} =40V, I _D =1A | - | 2.5 | - | S |
| Dynamic Characteristics (Note 4) | | | | | | |
| Input Capacitance | C _{iss} | V _{DS} =25V, V _{GS} =0V , F=1.0MHz | - | 380 | 490 | PF |
| Output Capacitance | C _{oss} | | - | 35 | 46 | PF |
| Reverse Transfer Capacitance | C _{rss} | | - | 7.6 | 9.9 | PF |
| Switching Characteristics (Note 4) | | | | | | |
| Turn-on Delay Time | t _{d(on)} | V _{DD} =300V, I _D =2A, R _G =2.5Ω | - | 16 | 40 | nS |
| Turn-on Rise Time | t _r | | - | 50 | 110 | nS |
| Turn-Off Delay Time | t _{d(off)} | | - | 40 | 90 | nS |
| Turn-Off Fall Time | t _f | | - | 40 | 90 | nS |
| Total Gate Charge | Q _g | V _{DS} =480V, I _D =2A , V _{GS} =10V | - | 15.3 | | nC |
| Gate-Source Charge | Q _{gs} | | - | 1.8 | | nC |
| Gate-Drain Charge | Q _{gd} | | - | 7.2 | | nC |
| Drain-Source Diode Characteristics | | | | | | |
| Diode Forward Voltage | V _{SD} | V _{GS} =0V, I _S =2A | - | | - | V |
| Diode Forward Current | I _S | | - | - | 2 | A |
| Reverse Recovery Time | t _{rr} | V _{GS} =0V, I _S =2A dI _F /dt=100A/us | - | 250 | - | nS |
| Reverse Recovery Charge | Q _{rr} | | - | 1.31 | - | nC |
| Forward Turn-On Time | t _{on} | Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD) | | | | |

Notes:

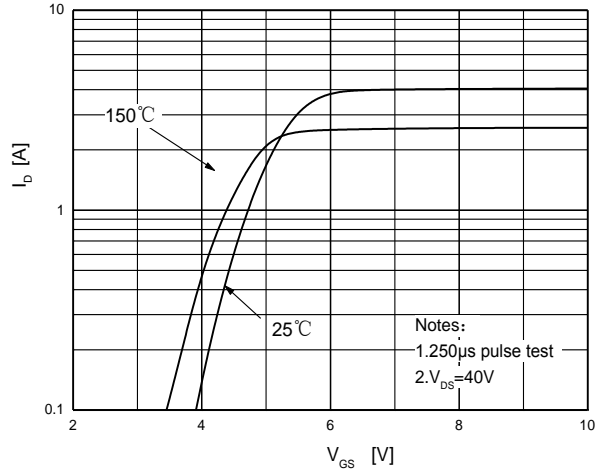
- 1: Pulse width limited by maximum junction temperature
- 2: L=55mH, I_{BASB}=2.0A, V_{BDDDB}=50V, R_{BGB}=25 Ω, Starting T_BJ_B=25°C
- 3: I_BS_{DB} ≤ 2A, di/dt ≤ 300A/μs, V_{DD} ≤ BV_{DSSB}, Starting T_BJ_B=25°C
- 4: Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%
- 5: Essentially independent of operating temperature

ELECTRICAL CHARACTERISTICS (curves)

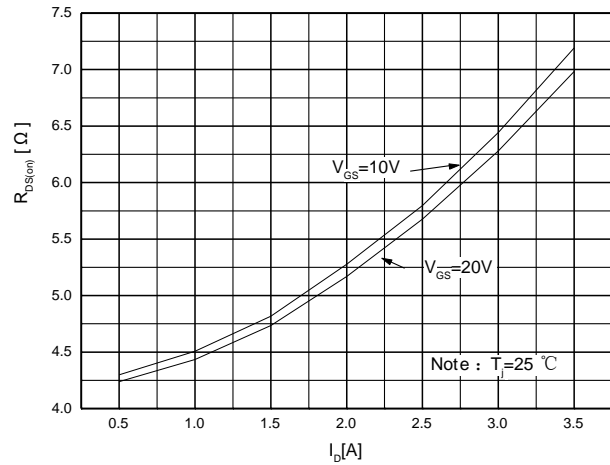
On-Region Characteristics



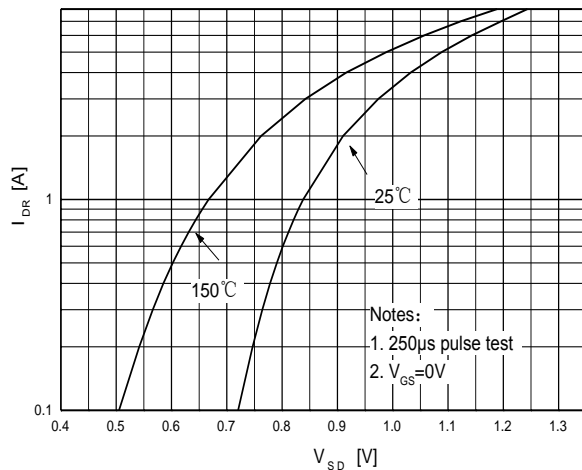
Transfer Characteristics



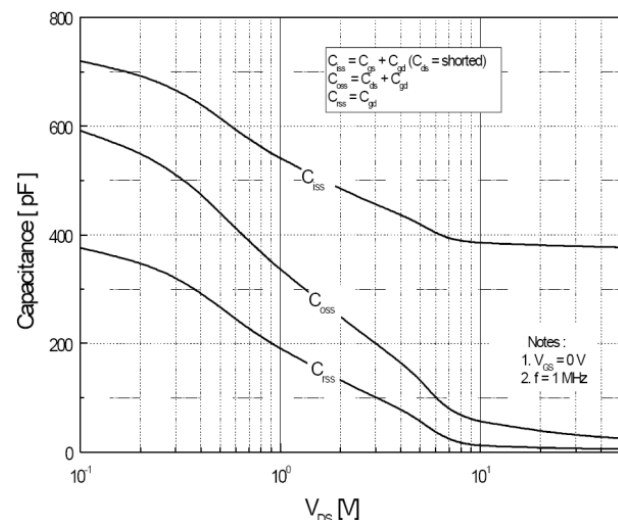
On-Resistance Variation vs. Drain Current and Gate Voltage



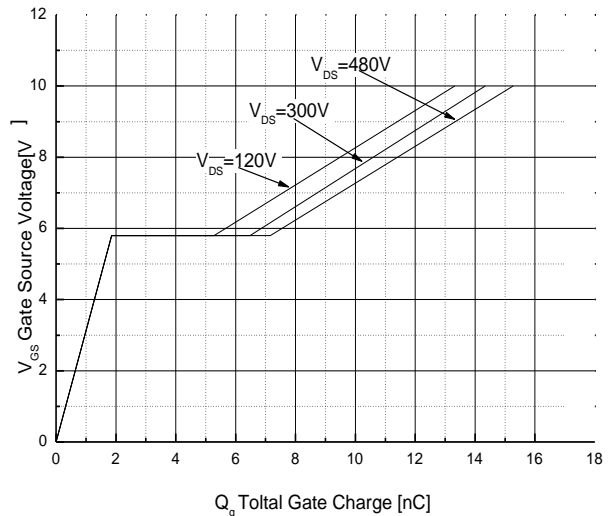
Body Diode Forward Voltage Variation vs. Source Current and Temperature



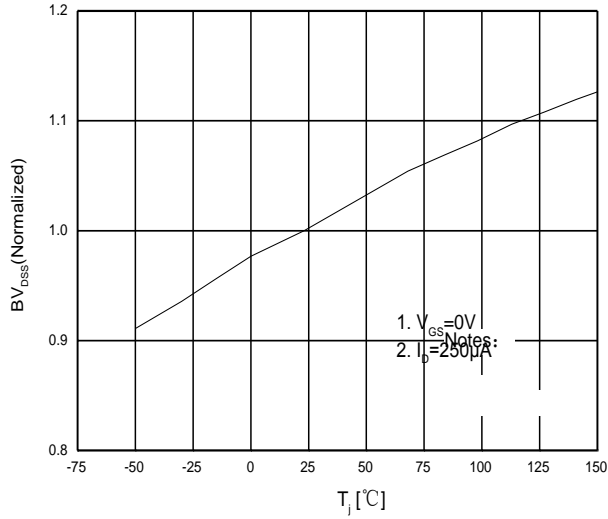
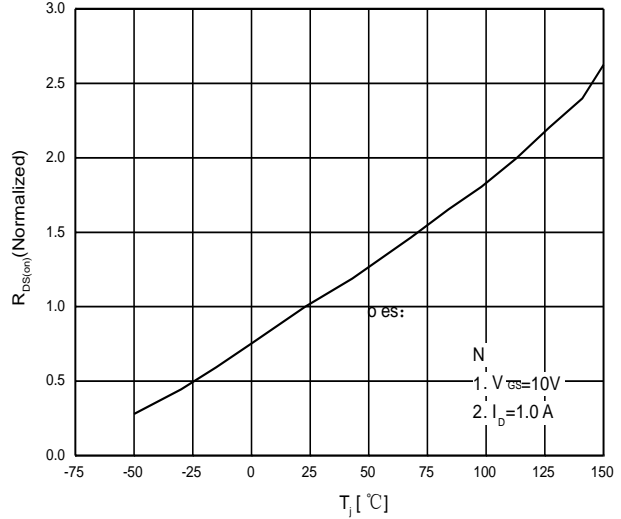
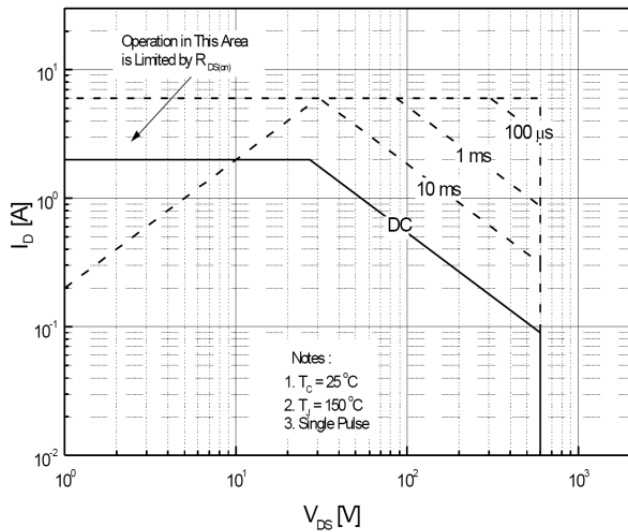
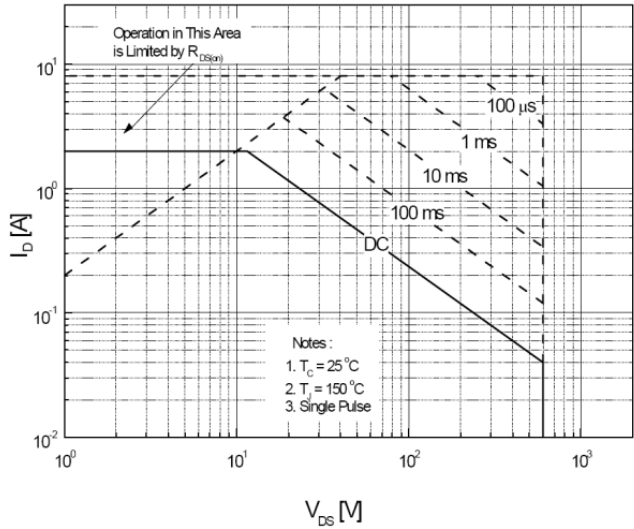
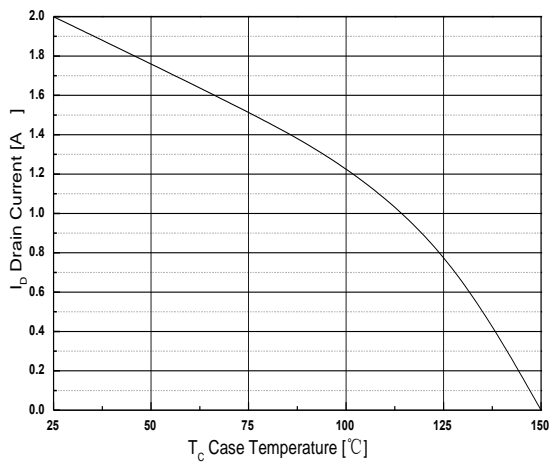
Capacitance Characteristics

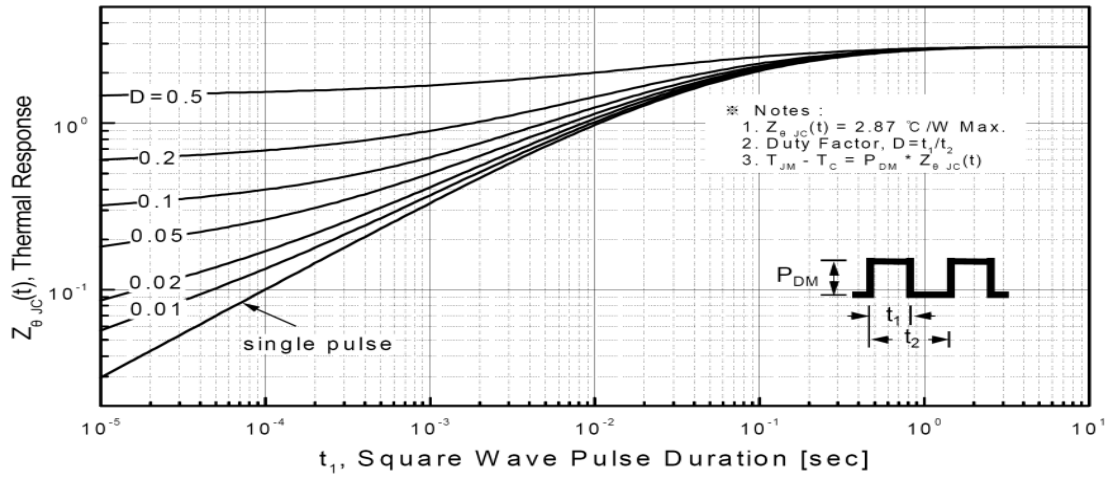
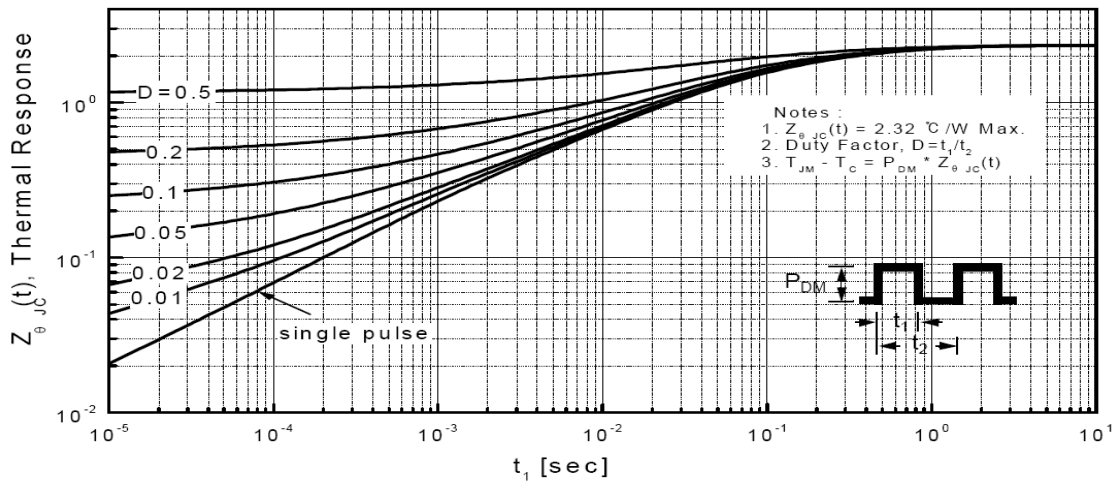


Gate Charge Characteristics



ELECTRICAL CHARACTERISTICS (curves)

Breakdown Voltage Variation vs. Temperature

On-Resistance Variation vs. Temperature

Maximum Safe Operating Area For JCS2N60V/R/C

Maximum Safe Operating Area For JCS2N60F

Maximum Drain Current vs. Case Temperature


ELECTRICAL CHARACTERISTICS (curves)
Transient Thermal Response Curve For JCS2N60V/R

Transient Thermal Response Curve For JCS2N60C

Transient Thermal Response Curve For JCS2N60F
